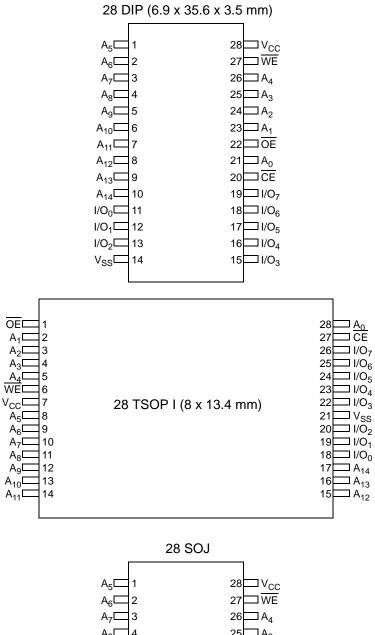
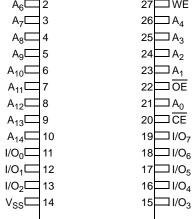


Pin Layout and Specifications





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Pin Description

Pin	Туре	Description	DIP	SOJ	TSOP I
A _X	Input	Address Inputs	1, 2, 3, 4, 5, 6, 7, 8, 9, 10, 21, 23, 24, 25, 26	1, 2, 3, 4, 5, 6, 7, 8, 9, 10, 21, 23, 24, 25, 26	2, 3, 4, 5, 8, 9, 10, 11, 12, 13, 14, 15, 16, 17, 28
CE	Control	Chip Enable	20	20	27
I/O _X	Input or Output	Data Input/Outputs	11, 12, 13, 15, 16, 17, 18, 19	11, 12, 13, 15, 16, 17, 18, 19	18, 19, 20, 22, 23, 24, 25, 26
ŌE	Control	Output Enable	22	22	1
V _{CC}	Supply	Power (5.0V)	28	28	7
V _{SS}	Supply	Ground	14	14	21
WE	Control	Write Enable	27	27	6

Maximum Ratings (Above which the useful life may be impaired. For user guidelines, not tested.)

Parameter	Description	Value	Unit
T _{STG}	Storage Temperature	-65 to +150	°C
T _{AMB}	Ambient Temperature with Power Applied (i.e., case temperature)	-55 to +125	°C
V _{CC}	Core Supply Voltage Relative to V _{SS}	-0.5 to +7.0	V
V _{IN} , V _{OUT}	DC Voltage Applied to any Pin Relative to V _{SS}	-0.5 to V _{CC} + 0.5	V
I _{OUT}	Output Short-Circuit Current	20	mA
V _{ESD}	Static Discharge Voltage (per MIL-STD-883, Method 3015)	> 2001	V
I _{LU}	Latch-up Current	> 200	mA

Operating Range

Range	Ambient Temperature (T _A)	Voltage Range (V _{CC})
Commercial	0°C to 70°C	5.0V ± 10%
Industrial	-40°C to 85°C	5.0V ± 10%

DC Electrical Characteristics Over the Operating Range [2]

				1	12 ns		5 ns	20 ns		
Parameter	Description	Condition		Min.	Max.	Min.	Max.	Min.	Max.	Unit
V _{IH}	Input HIGH Voltage			2.2	$V_{CC} + 0.3$	2.2	$V_{CC} + 0.3$	2.2	V _{CC} + 0.3	V
V _{IL}	Input LOW Voltage			-0.5	0.8	-0.5	0.8	-0.5	0.8	V
V _{OH}	Output HIGH Voltage	V_{CC} = Min., I_{OH} = -4.0 mA		2.4		2.4		2.4		V
V _{OL}	Output LOW Voltage	V_{CC} = Min., I_{OL} = 8.0 mA			0.4		0.4		0.4	V
I _{IX}	Input Leakage Current	$GND \leq V_I \leq V_{CC}$		- 5	+5	- 5	+5	- 5	+5	μА
I _{OZ}	Output Leakage Current	$\begin{aligned} &\text{GND} \leq V_I \leq V_{CC}, \text{Output} \\ &\text{Disabled} \end{aligned}$		- 5	+5	- 5	+5	- 5	+5	μА
I _{CC}	V _{CC} Operating Supply Current	$V_{CC} = Max., I_{OUT} = 0 mA,$ $f = F_{MAX} = 1/t_{RC}$			85		80		75	mA
I _{SB1}	Automatic CE	Max. V_{CC} , $\overline{CE} \ge V_{IH}$, $V_{IN} \ge$			30		30		30	mΑ
	Power-down Current TTL Inputs	V_{IH} or $V_{IN} \le V_{IL}$, $f = F_{MAX}$	L				10			mA
I _{SB2}	Automatic CE	Max. V_{CC} , $\overline{CE} \ge V_{CC} - 0.3V$,			10		10		10	mA
	Power-down Current CMOS Inputs	$V_{IN} \ge V_{CC} - 0.3V$, or $V_{IN} \le 0.3V$, f = 0	L				500			μА

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Note:
2. V_{IL} (min) = -2.0V for pulse durations of less than 20 ns.



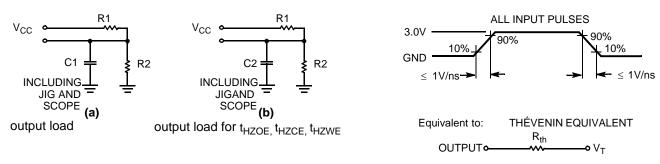
Capacitance^[3]

			Max.	
Parameter	Description	Conditions	ALL – PACKAGES	Unit
C _{IN}	Input Capacitance	$T_A = 25^{\circ}C, f = 1 \text{ MHz},$	8	pF
C _{OUT}	Output Capacitance	$V_{CC} = 5.0V$	8	

Thermal Resistance^[4]

Parameter	Description	Conditions	TSOP I	SOJ	DIP	Unit
Θ_{JA}	Thermal Resistance (Junction to Ambient)	Still Air, soldered on a 3 x 4.5 square inch, two-layer printed	88.6	79	69.33	°C/W
ΘJC	Thermal Resistance (Junction to Case)	circuit board	21.94	41.42	31.62	

AC Test Loads and Waveforms



- Notes:
 3. Tested initially and after any design or process change that may affect these parameters.
 4. Test Conditions assume a transition time of 3 ns or less, timing reference levels of 1.5V, input pulse levels of 0 to 3.0V.

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AC Test Conditions

Parameter	Description	escription Nom.		
C1	Capacitor 1	30	pF	
C2	Capacitor 2	5		
R1	Resistor 1	480	Ω	
R2	Resistor 2	255		
R _{TH}	Resistor Thevenin	167		
V_{TH}	Voltage Thevenin	1.73	V	

AC Electrical Characteristics^[5, 6, 7]

		12	ns	15 ns		20 ns		
Parameter	Description	Min	Max	Min	Max	Min	Max	Unit
t _{RC}	Read Cycle Time	12		15		20		ns
t _{AA}	Address to Data Valid		12		15		20	ns
t _{OHA}	Data Hold from Addres Change	3		3		3		ns
t _{ACE}	CE to Data Valid		12		15		20	ns
t _{DOE}	OE to Data Valid		5		7		9	ns
t _{LZOE}	OE to Low Z	0		0		0		ns
t _{HZOE}	OE to High Z		5		7		9	ns
t _{LZCE}	CE to Low Z	3		3		3		ns
t _{HZCE}	CE to High Z		5		7		9	ns
t _{PU}	CE to Power-up	0		0		0		ns
t _{PD}	CE to Power-down		12		15		20	ns
t _{WC}	Write Cycle Time	12		15		20		ns
t _{SCE}	CE to Write End	9		10		15		ns
t _{AW}	Address Set-up to Write End	9		10		15		ns
t _{HA}	Address Hold from Write End	0		0		0		ns
t _{SA}	Address Set-up to Write Start	0		0		0		ns
t _{PWE}	WE Pulse Width	8		9		15		ns
t _{SD}	Data Set-up to Write End	8		9		10		ns
t _{HD}	Data Hold from Write End	0		0		0		ns
t _{HZWE}	WE LOW to High Z		7		7		10	ns
t _{LZWE}	WE HIGH to Low Z	3		3		3		ns

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 ^{5.} At any given temperature and voltage condition, t_{HZCE} is less than t_{LZCE}, t_{HZOE} is less than t_{LZOE}, and t_{HZWE} is less than t_{LZWE} for any given device.
 6. The internal write time of the memory is defined by the overlap of CE LOW and WE LOW. CE and WE must be LOW to initiate a write, and the transition of any of these signals can terminate the write. The input data set–up and hold timing should be referenced to the leading edge of the signal that terminates the write.
 7. t_{HZOE}, t_{HZCE}, t_{HZWE} are specified as in part (b) of the A/C Test Loads. Transitions are measured ± 200 mV from steady state voltage.

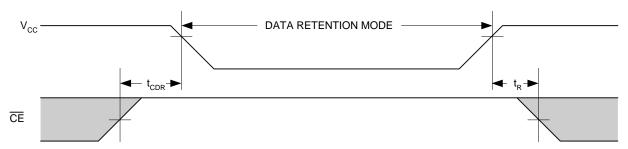


Data Retention Characteristics^[8]

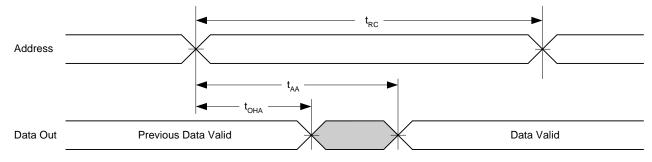
			Al	LL	
Parameter	Description	Condition	Min.	Max.	Unit
V_{DR}	V _{CC} for Data Retention		2.0	_	V
I _{CCDR}	Data Retention Current	$V_{CC} = V_{DR} = 2.0V, \overline{CE} \ge V_{CC} - 0.3V,$ $V_{IN} \ge V_{CC} - 0.3V \text{ or } V_{IN} \le 0.3V$	_	150	μА
t _{CDR}	Chip Deselect to Data Retention Time	$1V_{IN} \ge V_{CC} - 0.3V$ or $V_{IN} \le 0.3V$	0	_	ns
t _R	Operation Recovery Time		200	_	μS

Timing Waveforms

Data Retention Waveform



Read Cycle No. 1^[11, 10]



Notes:

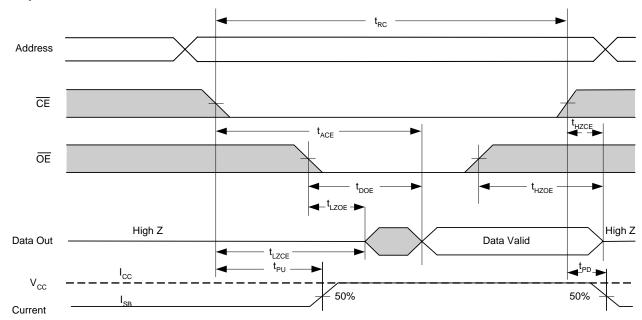
- 8. L-version only.
 9. <u>Device</u> is continuously selected. <u>OE</u> = V_{IL} = <u>CE</u>.
 10. <u>WE</u> is HIGH for Read Cycle.

[+] Feedback

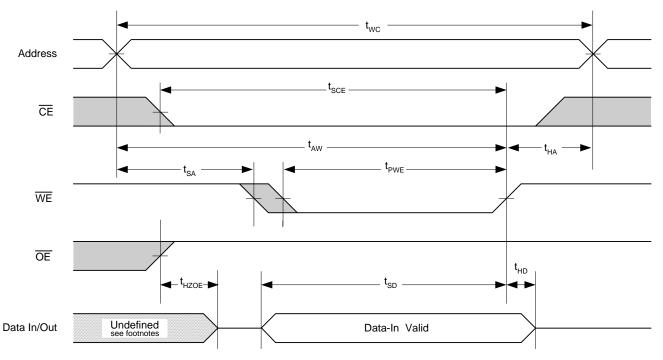


Timing Waveforms (continued)

Read Cycle No. 2^[11, 12]



Write Cycle No. 1 ($\overline{\text{WE}}$ Controlled)[13, 14, 15]



Notes:

- 11. This cycle is \overline{OE} Controlled and \overline{WE} is HIGH read cycle.

 12. Address valid prior to or coincident with \overline{CE} transition LOW.

 13. This cycle is \overline{WE} controlled, \overline{OE} is HIGH during write.

 14. Data In/Out is high impedance if $\overline{OE} = V_{IH}$.

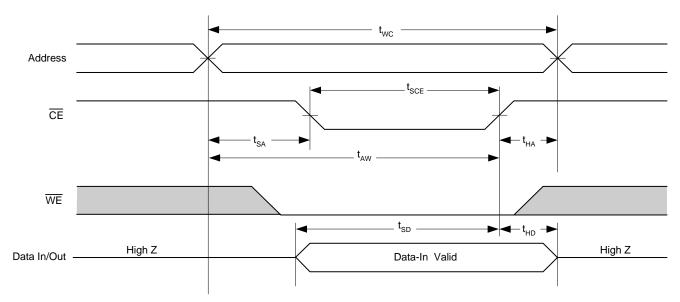
 15. During this period the I/Os are in output state and input signals should not be applied.

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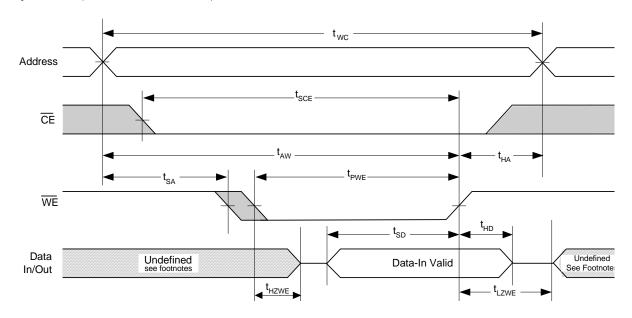


Timing Waveforms (continued)

Write Cycle No. 2 ($\overline{\text{CE}}$ Controlled)[14, 16, 17]



Write Cycle No. 3 ($\overline{\text{WE}}$ Controlled, $\overline{\text{OE}}$ Low)[18]



16. This cycle is $\overline{\text{CE}}$ controlled.

17. If $\overline{\text{CE}}$ goes HIGH simultaneously with $\overline{\text{WE}}$ going HIGH, the output remains in a high-impedance state.

18. The cycle is $\overline{\text{WE}}$ controlled, $\overline{\text{OE}}$ LOW. The minimum write cycle time is the sum of t_{HZWE} and t_{SD} .



Truth Table

CE	WE	OE	Input/Output	Mode	Power
Н	Х	Х	High Z	Deselect/Power-Down	Standby (I _{SB})
L	Н	L	Data Out	Read	Active (I _{CC})
L	L	Х	Data In	Write	Active (I _{CC})
L	Н	Н	High Z	Deselect	Active (I _{CC})

Ordering Information

Speed	Ordering Code	Package Name	Package Type	Operating Range
12	CY7C199C-12VC	51-85031	28-pin (300-Mil) Molded SOJ	Commercial
	CY7C199C-12VXC	1	28-pin (300-Mil) Molded SOJ (Pb-Free)	
	CY7C199C-12ZXC	51-85071	28-pin TSOP I (Pb-Free)	
	CY7C199C-12VI	51-85031	28-pin (300-Mil) Molded SOJ	Industrial
15	CY7C199C-15PC	51-85014	28-pin (300-Mil) DIP	Commercial
	CY7C199C-15PXC	1	28-pin (300-Mil) DIP (Pb-Free)	
	CY7C199C-15ZC	51-85071	28-pin TSOP I	
	CY7C199C-15ZXC	1	28-pin TSOP I (Pb-Free)	
	CY7C199C-15VC	51-85031	28-pin (300-Mil) Molded SOJ	
	CY7C199C-15VXC	1	28-pin (300-Mil) Molded SOJ (Pb-Free)	
	CY7C199CL-15VC	1	28-pin (300-Mil) Molded SOJ	
	CY7C199CL-15VXC	1	28-pin (300-Mil) Molded SOJ (Pb-Free)	
	CY7C199C-15VI	51-85031	28-pin (300-Mil) Molded SOJ	Industrial
20	CY7C199C-20ZXI	51-85071	28-pin TSOP I (Pb-Free)	Industrial

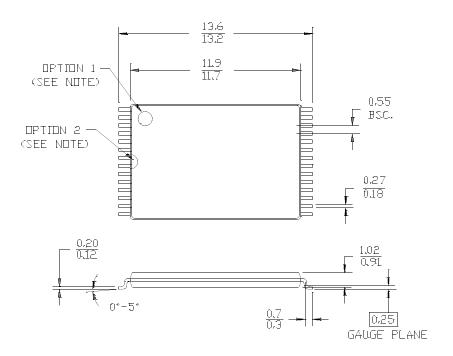
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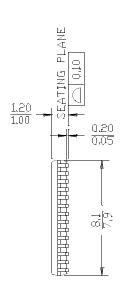


Package Diagrams

28-pin TSOP 1 (8 x 13.4 mm) (51-85071)

NOTE: ORIENTATION I.D MAY BE LOCATED EITHER AS SHOWN IN OPTION 1 OR OPTION 2





DIMENSION IN MM MAX. MIN.

51-85071-*G

[+] Feedback

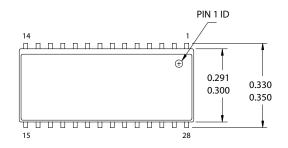


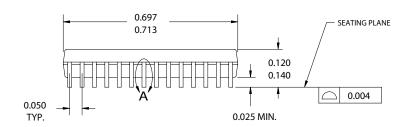
Package Diagrams (continued)

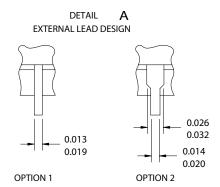
28-pin (300-Mil) Molded SOJ (51-85031)

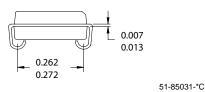
NOTE:

- 1. JEDEC STD REF MO088
- 2. BODY LENGTH DIMENSION DOES NOT INCLUDE MOLD PROTRUSION/END FLASH MOLD PROTRUSION/END FLASH SHALL NOT EXCEED 0.006 in (0.152 mm) PER SIDE
- 3. DIMENSIONS IN INCHES MIN. MAX.







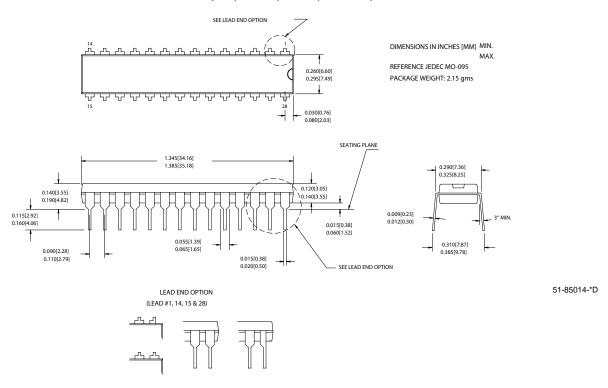


[+] Feedback



Package Diagrams (continued)

28-pin (300-Mil) PDIP (51-85014)



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Document History Page

REV.	ECN No.	Issue Date	Orig. of Change	Description of Change
**	129233	09/11/03	HGK	New Data Sheet
*A	129697	09/15/03	KKV	Minor change: Move Product Portfolio from page 4 to page 1 Move Truth table from page 9 to page 3
*B	341574	See ECN	PCI	Added Lead-Free part to Ordering info on Page #10
*C	492500	See ECN	NXR	Removed 25 ns speed bin Changed the description of I _{IX} from Input Load Current to Input Leakage Current in DC Electrical Characteristics table Removed I _{OS} parameter from DC Electrical Characteristics table Updated the ordering information table

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